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# United States Patent [19]

Heidsiek et al.

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[45] **Date of Patent: \*\* May 18, 1999**

[54] **DIAGNOSTIC TESTING INSTRUMENT**

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[73] Assignee: **Gen-Probe Incorporated**, San Diego, Calif.

[\*\*] Term: **14 Years**

[21] Appl. No.: **29/078,352**

[22] Filed: **Oct. 13, 1997**

[51] **LOC (6) Cl.** ..... **29-02**

[52] **U.S. Cl.** ..... **D24/107**

[58] **Field of Search** ..... D24/107, 185, D24/186, 234; 128/630, 906; 422/50, 62, 64; 436/43-45, 55; 364/140.09, 497, 480, 180

[56] **References Cited**

**U.S. PATENT DOCUMENTS**

D. 282,203 1/1986 Leonard et al. .... D24/107

D. 326,908 6/1992 Gilbert et al. .... D24/107  
D. 369,564 5/1996 Whitby et al. .... D24/234  
5,147,610 9/1992 Watanabe et al. .... 422/64  
5,270,210 12/1993 Weyrauch et al. .... 422/64 X

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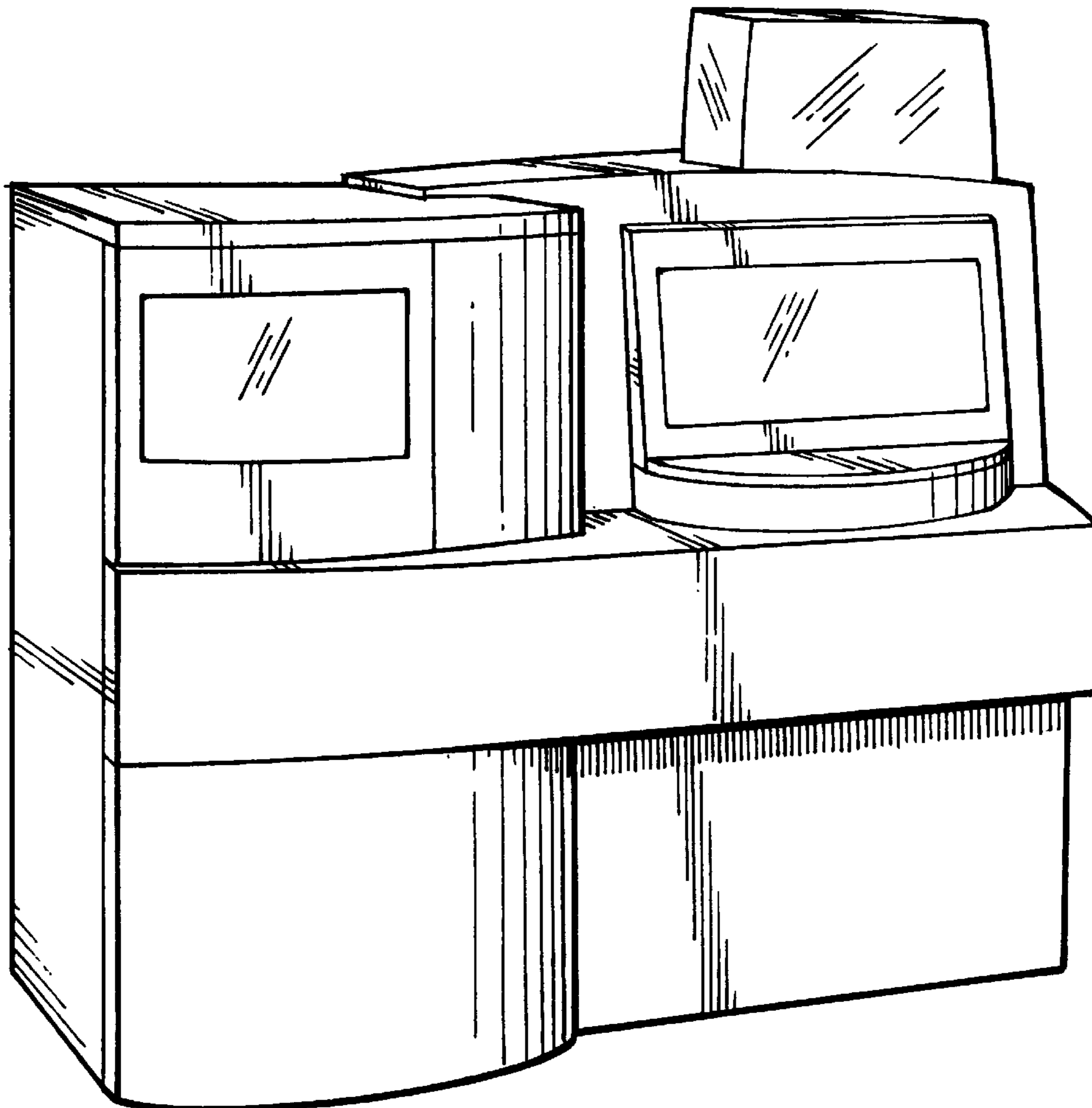
[57] **CLAIM**

The design for a diagnostic testing instrument, as shown and described.

**DESCRIPTION**

FIG. 1 is a top, front and left side perspective view of our new design for a diagnostic testing instrument;  
FIG. 2 is a top, front and right side perspective view thereof;  
FIG. 3 is a front elevation view thereof;  
FIG. 4 is a plan view thereof;  
FIG. 5 is a rear elevation view thereof;  
FIG. 6 is a left side elevation view thereof; and,  
FIG. 7 is right side elevation view thereof.

**1 Claim, 5 Drawing Sheets**



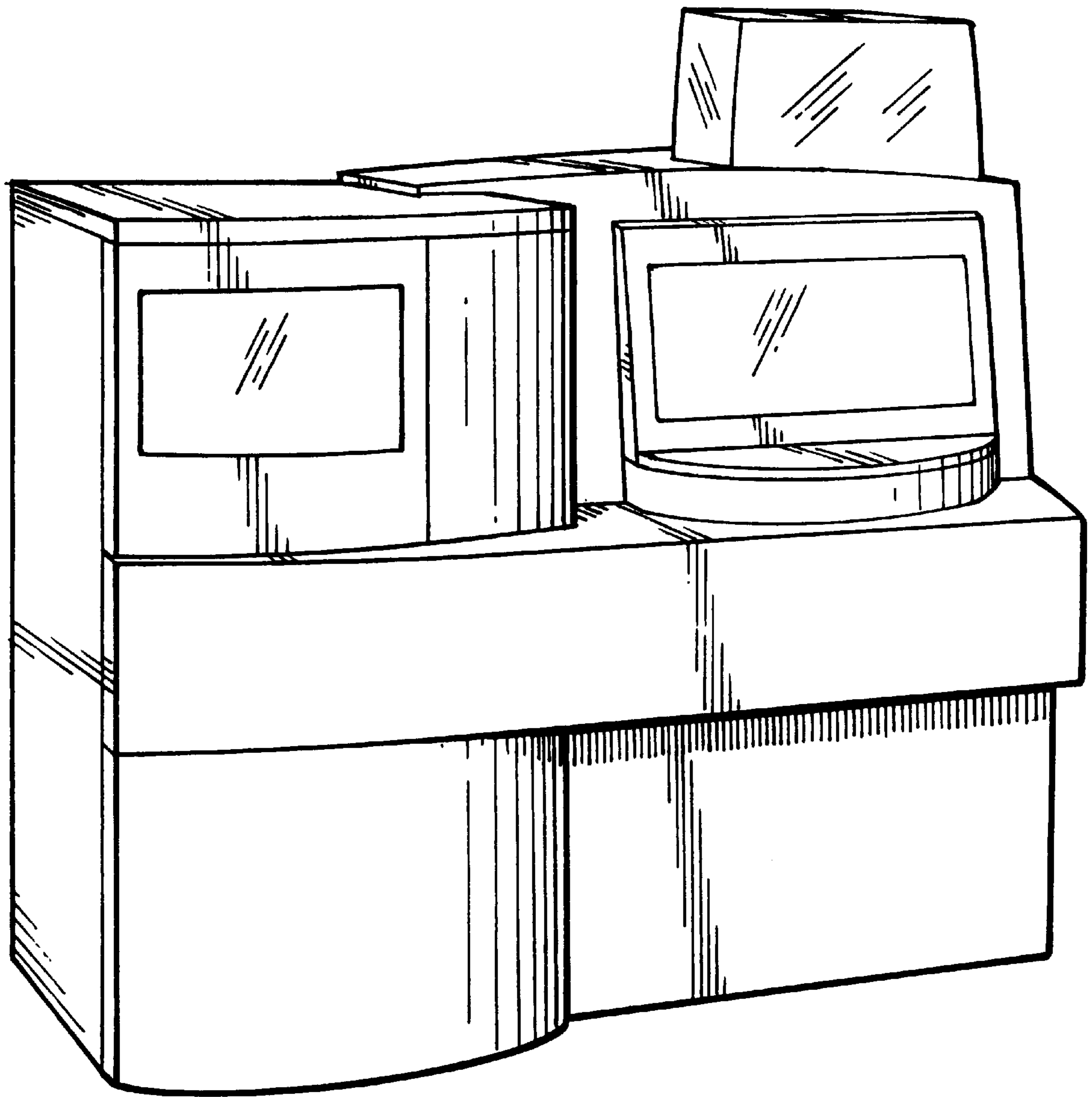


Fig. 1

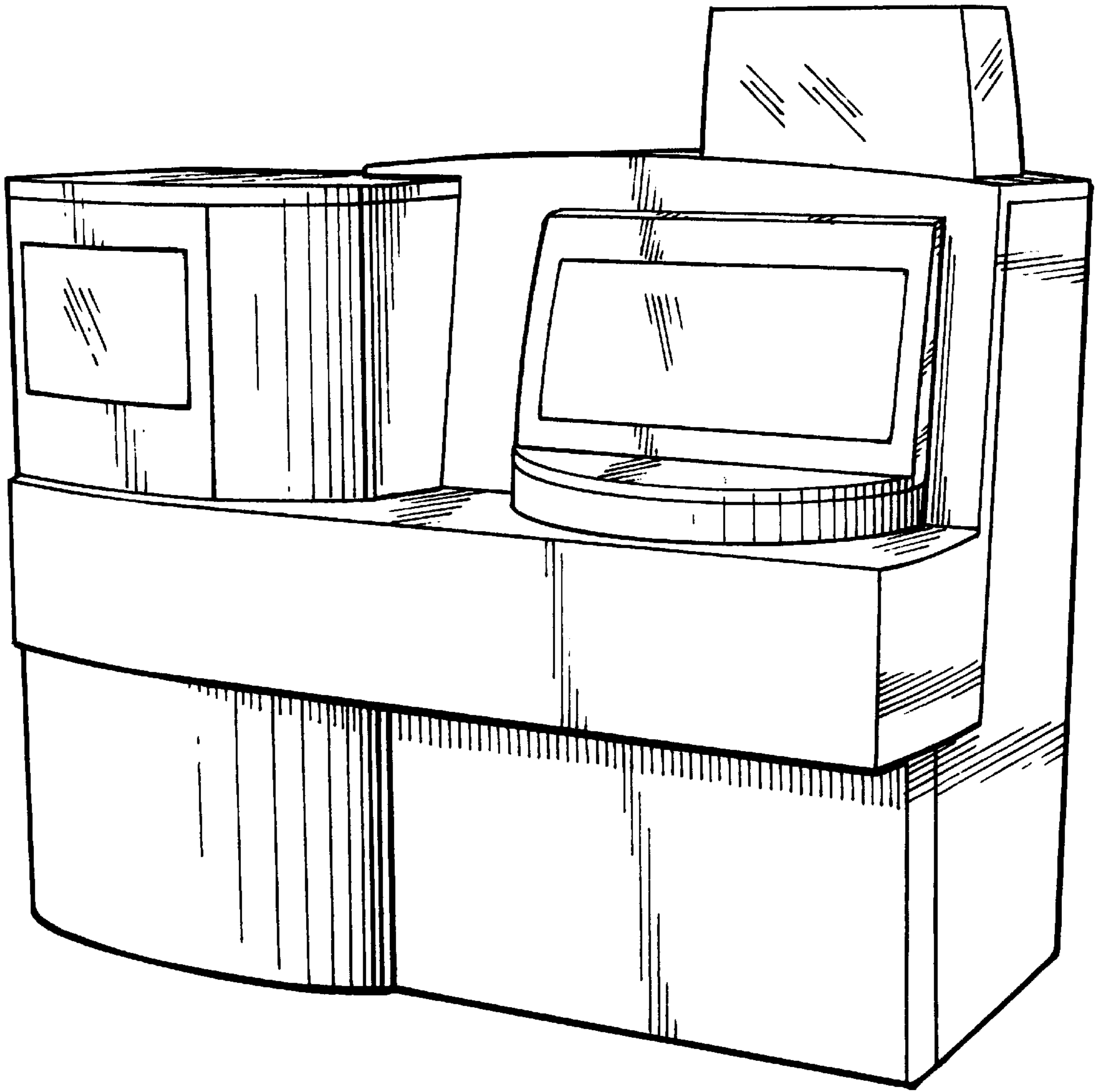


Fig. 2

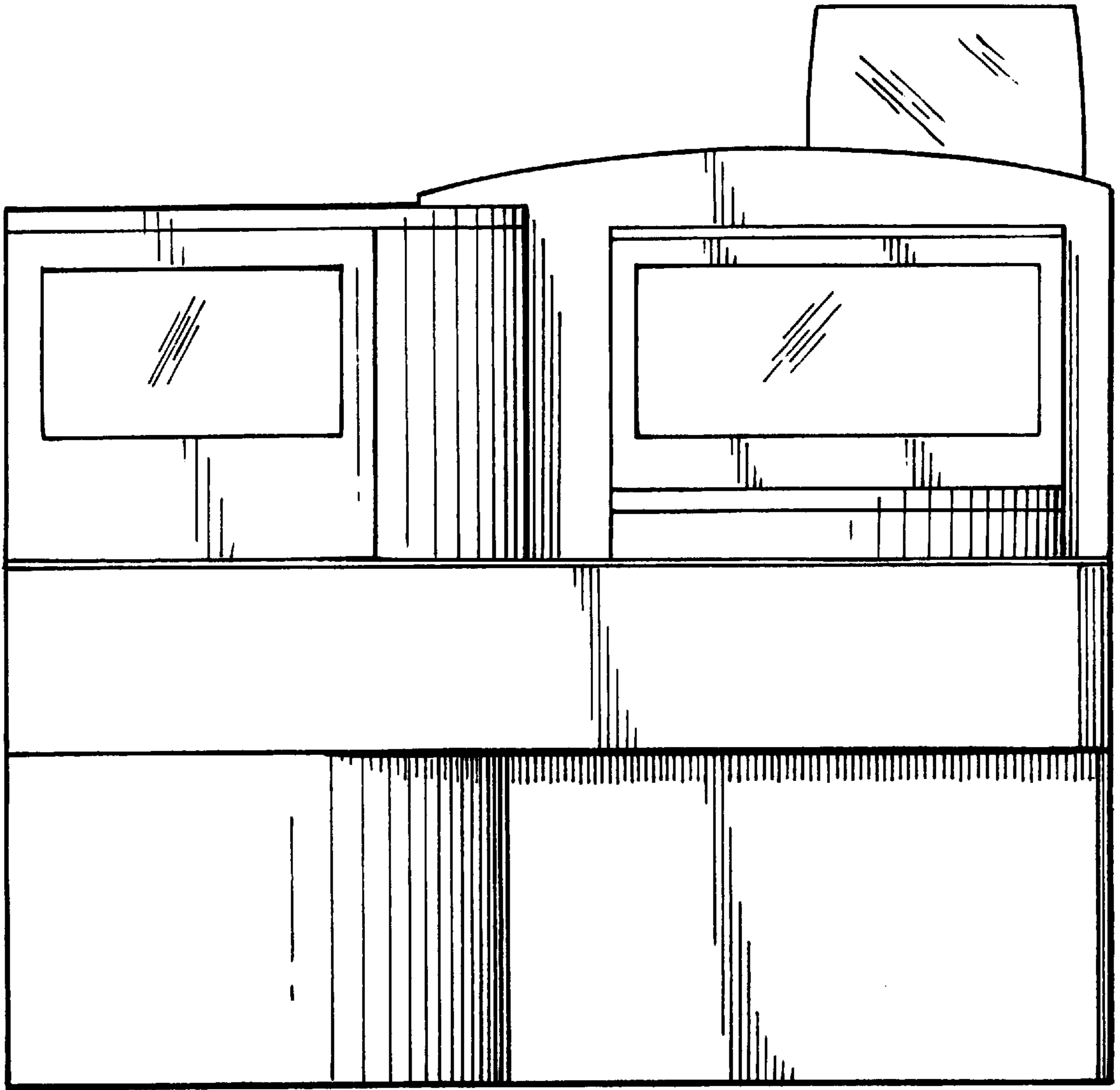


Fig. 3

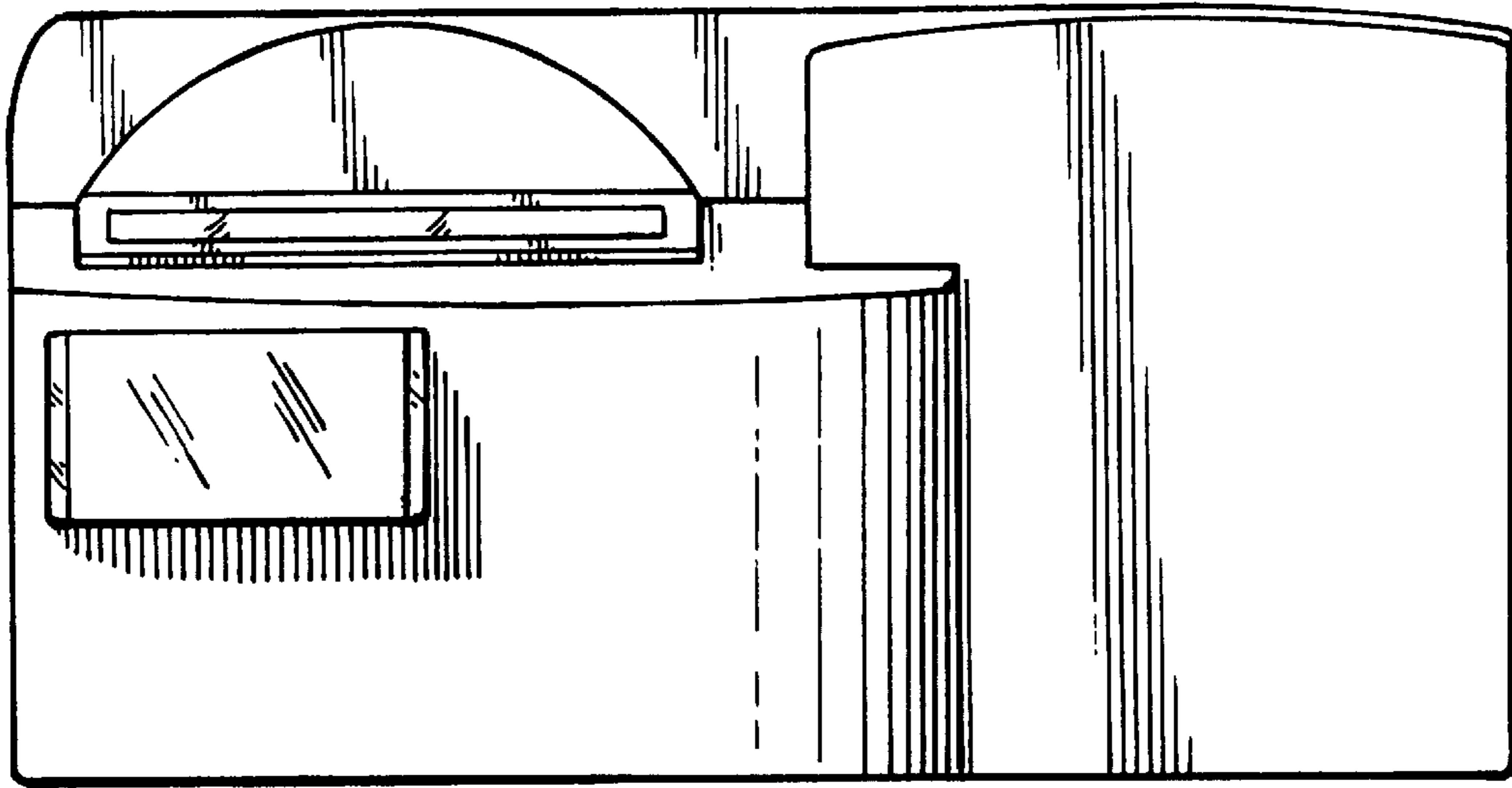


Fig. 4

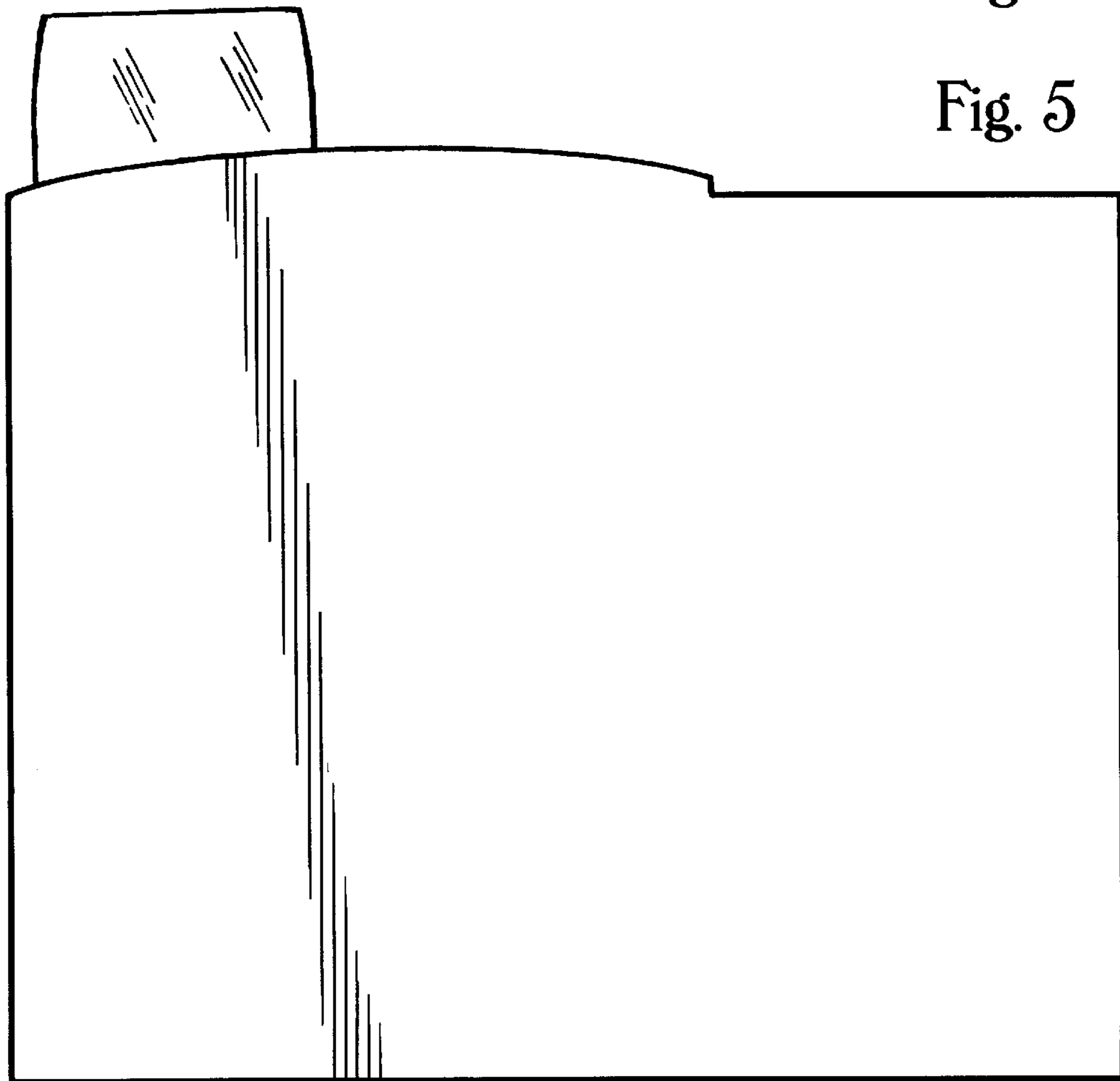


Fig. 5

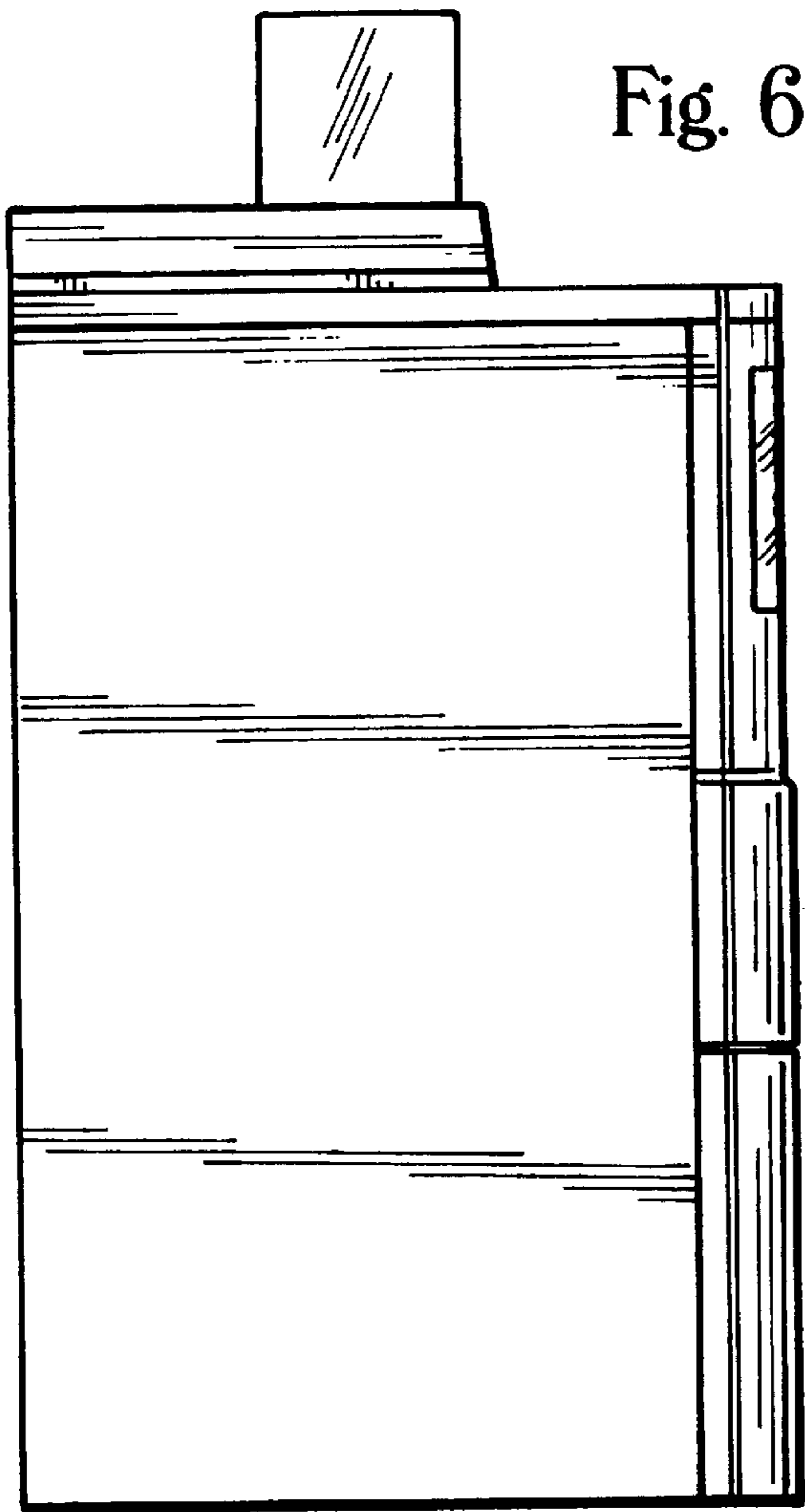


Fig. 6

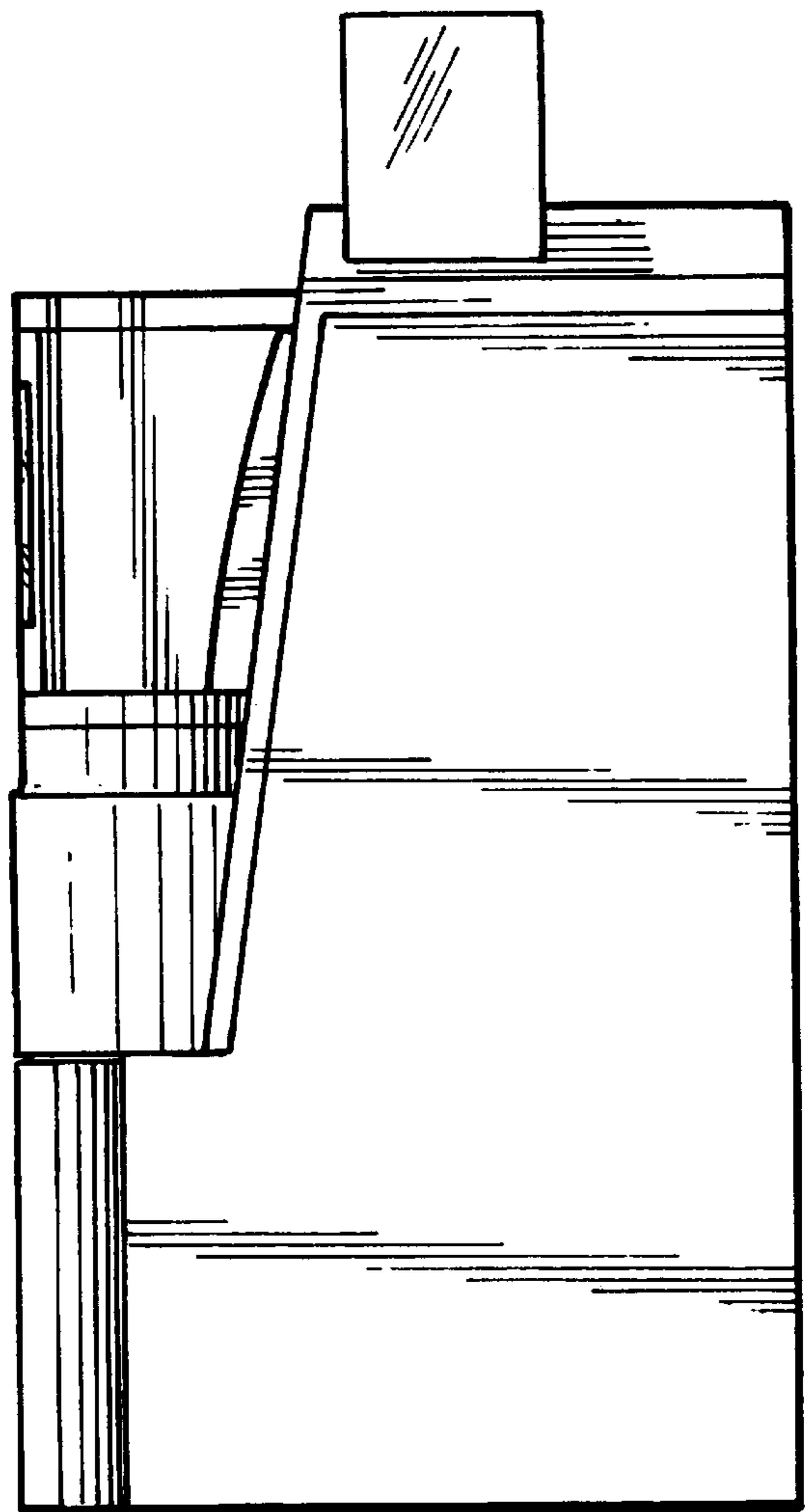


Fig. 7